

Notice of References Cited	Application/Control No. 10/700,338		Applicant(s)/Patent Under Reexamination CIRNE ET AL.	
	Examiner ZHENG WEI		Art Unit 2192	Page 1 of 1

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*	B	US-6,139,198	10-2000	Danforth et al.	717/128
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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